

# Test Report Summary

## No B41-17-BA summary

### PRIME Certification Tests Cases for Service Nodes

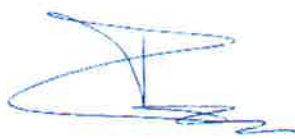
<b>EQUIPMENT UNDER TEST</b>	SINGLE PHASE PRIME SERVICE NODE
<b>MODEL</b>	STCOMET10
<b>FIRMWARE VERSION</b>	00-2744c
<b>CERTIFICATION SCOPE<sup>1</sup></b>	Chip (reference design)
<b>MANUFACTURER</b>	STMicroelectronics
<b>APPLICANT</b>	STMicroelectronics
<b>DATE OF RECEPTION</b>	6th September 2017
<b>PRIME SPECIFICATION VERSION</b>	PRIME-Specs v1.4
<b>TEST CASE VERSION</b>	PRIME Certification 1.4 Test book v2.2
<b>DATE OF EXECUTION</b>	6th to 15th September 2017
<b>DATE OF ISSUE OF REPORT</b>	Brussels 26th September 2017

Responsible for tests



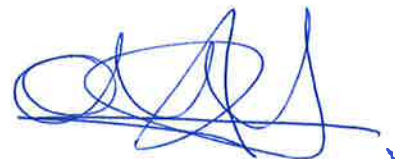
Beñat López

ICT Services Director



Ibon Arechalde

PRIME Alliance Vice President



Oscar Marquez

- \* This test report summary is granted on account of tests made at location of TECNALIA: Parque Tecnológico de Bizkaia, c/ Geldo Edificio 700 E-48160 Derio – Bizkaia- Spain.
- \* The results of the present report apply only to the samples tested and the moment and conditions under which the measurements were performed.
- \* The complete results, including remarks and limitations, are laid down in our complete test report no. B41-17-BA which can be obtained at TECNALIA. The certificate and the test report are indivisible.
- \* The test report summary is issued by PRIME Alliance. It shall not be reproduced, in total or in part and in whatever way, without written permission of TECNALIA

<sup>1</sup> IMPORTANT: Remarks apply to the implementation of this function. See complete test report (ANNEX I) for full details